

Application/Control No.	Applicant(s)/Patent under Reexamination						
10/785,377	PHILYAW ET AL.						
Examiner	Art Unit						

ISSUE CLASSIFICATION													
ORIGINAL CROSS REFERENCE(S)													
CLASS	SUBCLASS	CLASS											
2) (3	380	211						1	1		T	
INTERNATIONAL C		500	21	-					+			+	
							-		 -			┼	
6068	1/04,58								<u></u>			ļ	
506 F 15716													
KOGF 17/30					,								
(+0 6K 9100												T	
606K	19/00				_								
Benjamin E. Can'er Bull 26/66 (Assistant Examiner) (Date)			GILBERTO BARRON SUPERVISORY PATENT EXAMINER						Total Claims Allowed: Ιλ				
Kim IV variables		S	TECHNOLOGY CENTER 2100						Print Claim(s)			Print Fig.	
(Legal Instrume	ints Examiner)	P#19/2/11	\sim	(Prima	ry Examiner)	ē	(Pate) [· l	1	!
		HOOLU				\	153	1 /26					
Claims renu	mbered in the s	same orde	r as pre	sente	ed by appl	icant		PA			-	□R	1 47
								1 1			=	<u> </u>	
Final	Final	Final	Original		Final Original		Final	Original		Final	Original	Final	Original
1	31		61		91	1		121		1	51		181
2 2	32		62		92			122			52		182
3 3	33		63		93			123	L		53		183
4 5 5	34	ļ -	64 65	-	94			124	-		54 55		184
6 6	36		66		96	1		126	}		56	 -	185 186
1 7	37		67		97	1		127	F		57		187
8 8	38		68		98	1 :		128	F		58		188
9 9	39		69		99]		129			59		189
(V) 10	40		70	<u> </u>	100			130	-		60		190
11 11 12	41	-	71 72	-	101			131	F		61	 	191
13	43		73	-	102 103	-		132	}		62 63		192 193
14	44		74		104			134	-		64		194
15	45		75		105	1 1		135	r		65		195
16	46		76		106]		136			66		196
17	47		77		107			137			67		197
18	48		78	_	108			138	L		68		198
19 20	49 50		79 80	-	109 110	-		139 140	-		69 70		199
21	51		81	-	111	1	-	141	-		71		200
22	52		82	一	112	1		142	H		72		202
23	53		83		113]		143			73		203
24	54		84		114			144		1	74		204
25	55		85	L	115			145			75		205
26	56 57		86 87	-	116	4		146			76		206
28	58		88	-	117 118	1		147	-		77 78		207
29	59		89	-	119	1		149	-		79 79		208

Benjamin E. Lanier